

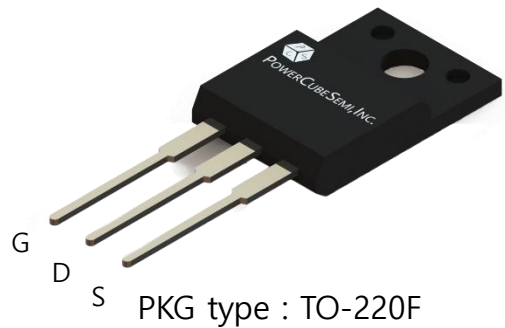
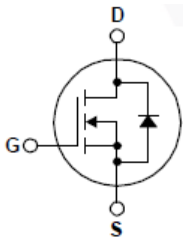
# PSP007N065HR

650V 7A 1.021Ω Si Single N-channel Planar MOSFET

## Features

### Si Single N-channel Planar MOSFET

- Rated to 650V at 7Amps @ $T_j = 25^\circ\text{C}$
- Max  $R_{DS(on)} = 1.28 \Omega$
- Typ  $R_{DS(on)} = 1.021 \Omega$
- Low Gate Charge(Typ.  $Q_g=15.6 \text{ nC}$ )
- Low Crss (Typ.  $Crss=1.5 \text{ pF}$ )
- Fast Switching
- 100% avalanche tested
- Improved dv/dt capability



## Absolute Maximum Ratings

Symbol	Parameter	Test Condition	Value	Unit
$BV_{DSS}$	Drain-Source Breakdown Voltage	$V_{GS}=0V, I_D=250\mu A$	650	V
$I_D$	Drain Current	$T_c=25^\circ\text{C}$	7	A
$I_{DM}$	Pulsed Drain Current	Pulse width limited by junction temperature	28	A
$V_{GS}$	Gate-Source Voltage		$\pm 30$	V
$E_{AS}$	Single Pulsed Avalanche Energy		247	mJ
$P_d$	Power Dissipation	$T_c=25^\circ\text{C}$	32.9	W
$T_j$	Operating Junction Temperature		-55 to 150	$^\circ\text{C}$
$T_{stg}$	Storage Temperature		-55 to 150	$^\circ\text{C}$

## Package Marking and Ordering Information

Device Marking	Device	Package	Packing Method	Tape width	Quantity
PSP007N065HR	PSP007N065	TO-220F	Tube	-	50 Unit

## Electrical Characteristics of Si MOSFET

Symbol	Parameter	Test Condition	Numerical			Unit
			Min	Typ.	Max.	
$BV_{DSS}$	Drain-Source Breakdown Voltage	$V_{GS} = 0V, I_D = 250\mu A, T_J = 25^\circ C$	650	-	-	V
$BV_{DSS}/\Delta T_J$	Breakdown Voltage Temperature Coefficient	$I_D = 250\mu A, \text{Referenced to } T_J = 25^\circ C$	-	0.59	-	V/°C
$I_{DSS}$	Zero gate voltage drain current	$V_{DS} = 650V, V_{GS} = 0V$	-	-	1	$\mu A$
$I_{GSS}$	Gate-source leakage current	$V_{GS} = \pm 30V, V_{DS} = 0V$	-	-	$\pm 100$	nA
$V_{GS(th)}$	Gate threshold voltage	$V_{DS} = V_{GS}, I_D = 250\mu A$	2	-	4	V
$R_{DS(ON)}$	Static drain-source on state resistance	$V_{GS} = 10V, I_D = 3.5A$	-	1.021	1.28	$\Omega$
$g_{FS}$	Forward Transconductance	$V_{DS} = 40V, I_D = 3.5A$	-	7	-	S
$t_{d(on)}$	Turn-on Delay time	$V_{DS} = 325V, I_D = 7A, R_G = 25\Omega$	-	12	-	ns
$T_r$	Turn-on Rise time		-	26	-	
$t_{d(off)}$	Turn-off Delay time		-	29	-	
$T_f$	Turn-off Fall time		-	27	-	



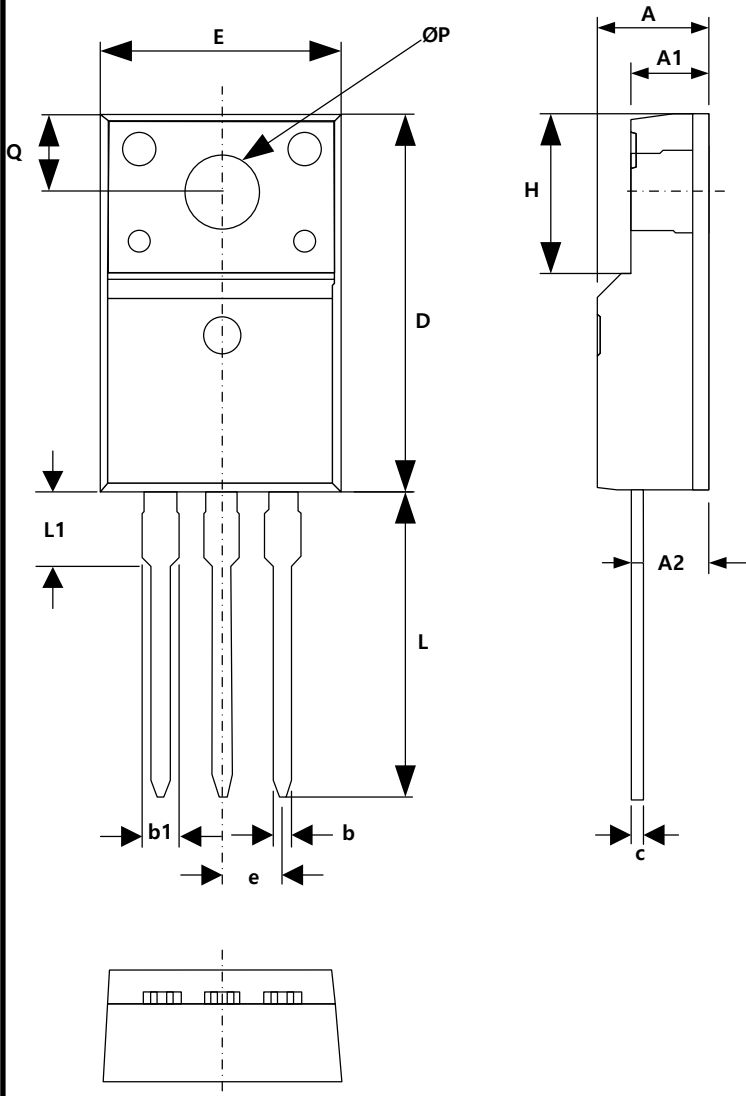
## Electrical Characteristics of Si MOSFET

Symbol	Parameter	Test Condition	Numerical		Unit
			Typ.	Max.	
$R_{\theta JC}$	Thermal resistance, Junction to case		3.8	-	$^{\circ}\text{C}/\text{W}$
$C_{iss}$	Input capacitance	$V_{DS} = 25\text{V}, V_{GS} = 0\text{V},$ $f = 1.0\text{MHz}$	800	-	pF
$C_{oss}$	Output capacitance		101	-	
$C_{rss}$	Reverse transfer capacitance		1.5	-	
$Q_{g(\text{tot})}$	Total gate charge	$V_{DS} = 52\text{V}, I_D = 7\text{A}$ $V_{GS(\text{on})} = 10\text{V}$	15.6	-	nC
$Q_{gs}$	Gate to source gate charge		4.8	-	
$Q_{gd}$	Gate to drain "Miller" charge		4.1	-	

## Electrical Characteristics of Si Diode

Symbol	Parameter	Test Condition	Numerical		Unit
			Typ.	Max.	
$I_S$	Maximum continuous drain to source diode forward current		-	7	A
$I_{SM}$	Maximum pulsed drain to source diode forward current		-	28	A
$V_{SD}$	Drain to source diode forward voltage	$I_{SD} = 7\text{A}, V_{GS} = 0\text{V}$	-	1.2	V
$T_{rr}$	Reverse recovery time	$V_{GS} = 0\text{V}, I_S = 7\text{A},$ $di_f/dt = 100\text{A}/\mu\text{s}$	389	-	ns
$Q_{rr}$	Reverse recovery charge		2.04	-	$\mu\text{C}$

### Package Outline



[Unit : mm]

SYMBOL	DIMENSIONS		NOTES
	MIN	MAX	
A	4.50	4.90	
A1	2.34	2.74	
A2	2.56	2.96	
b	0.70	0.90	
b1	1.27	1.47	
c	0.45	0.60	
D	15.67	16.07	
E	9.96	10.36	
e	2.54 BSC		
H	6.48	6.88	
L	12.68	13.28	
L1	3.03	3.43	
$\phi P$	3.08	3.28	
Q	3.20	3.40	